TOSHIBA Photocoupler GaAlAs Ired & Photo IC

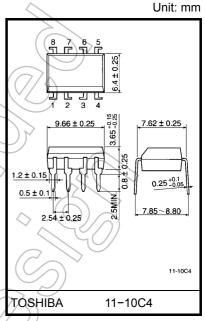
6N135, 6N136

Digital Logic Isolation Line Receiver Power Supply Control Switching Power Supply Transistor Inverter

The TOSHIBA 6N135 and 6N136 consists of a high emitting diode and a one chip photo diode–transistor.

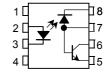
Each unit is 8-lead DIP package.

- Isolation voltage: 2500 V_{rms} (min)
- High speed: t_{pHL} , $t_{pLH} = 0.5 \mu s$ (typ.) ($R_L = 1.9 k\Omega$)
- TTL compatible
- If base pin is open, output signal will be noisy by environmental condition. For this base, TLP550 is suitable
- UL recognized: UL1577, file no. E67349

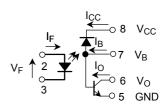


Weight: 0.54 g (typ.)

Pin Configurations



- 1 : N.C.
- 2: ANODE
- 3 : CATHODE
- 4 : N.C
- 5: EMITTER
- 6 : COLLECTOR
- 7 : BASE, ANODE
- 8 : CATHODE



Absolute Maximum Ratings (Ta = 25°C)

	Characteristic	Symbol	Rating	Unit		
ΓΕD	Forward current	(Note 1)	lF	25	mA	
	Pulse forward current	(Note 2)	I _{FP}	50	mA	
	Total pulse forward current	(Note 3)	I _{FPT}	1	Α <	
	Reverse voltage		V_{R}	5	V	
	Diode power dissipation	(Note 4)	P_{D}	45	mW	
Detector	Output current		Io	8	mA	
	Peak output current		I _{OP}	16	mA	
	Emitter-base reverse voltage (pin 5-7)		V _{EB}	5	X	
	Supply voltage		V _{CC}	-0.5 to 15	$\langle v \rangle \gamma$	
	Output voltage		Vo	-0.5 to 15	V	
	Base current (pin 7)		ΙΒ	5	mA	
	Output power dissipation	(Note 5)	Po	100	mW	
Operating temperature range		T _{opr}	-55 to 100	°C 🔷		
Storage temperature range			T _{stg}	-55 to 125	°C	
Lead solder temperature (10s) (Note 6)		(Note 6)	T _{sol}	260	°C((
Isolation voltage		(Note 7)	BVS	2500	V _{rms}	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

2

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

- (Note 1) Derate 0.8 mA above 70°C.
- (Note 2) 50% duty cycle, 1ms pulse width.

 Derate 1.6 mA / °C above 70°C.
- (Note 3) Pulse width 1µs, 300pps.
- (Note 4) Derate 0.9 mW / °C above 70°C.
- (Note 5) Derate 2 mW / °C above 70°C.
- (Note 6) Soldering portion of lead: Up to 2mm from the body of the device.
- (Note 7) R.H. ≤ 60%, AC, 1minute

Electrical Characteristics Over Recommended Temperature (Ta = 0°C~70°C unless otherwise noted)

Characteristic		Symbol	Test Condition	Min	(**)Typ.	Max	Unit
	6N135	CTR	I _F = 16mA, V _O = 0.4V V _{CC} = 4.5V, Ta = 25°C (Note 8)	7	18	_	%
Current transfer ratio	6N136	CIR		19	24	_	%
Current transfer fatto	6N135	CTR	I _F = 16mA, V _O = 0.5V	5	13	_	%
	6N136	CIR	$V_{CC} = 4.5V$ (Note 1)	(15	21	_	%
Logic low output voltage	6N135	V _{OL}	I _F = 16mA, I _O = 1.1mA V _{CC} = 4.5V		0.1	0.4	٧
Logic low output voltage	6N136	VOL	I _F = 16mA, I _O = 2.4mA V _{CC} = 4.5V		0.1	0.4	٧
Logic high output current		Іон	I _F = 0mA, V _O = V _{CC} = 5.5V Ta = 25°C	<u> </u>	3	500	nA
			I _F = 0mA, V _O = V _{CC} = 15V Ta = 25°C	- /	0.1	7	μА
		Гон	$I_F = 0 \text{ mA}, V_O \neq V_{CC} = 15V$	-6	7-//	50	μА
Logic low supply current		ICCL	I _F = 16mA, V _O = open V _{CC} = 15V	4	40) —	μА
Logic high supply current		Іссн	I _F = 0mA, V _O = open V _{CC} = 15V, Ta = 25°C	7	0.01	1	μА
		Іссн	J _F = 0mA, V _O = open V _{CC} = 15V		_	2	μΑ
Input forward voltage		VF	I _F = 16mA, Ta = 25°C) —	1.65	1.7	V
Temperature coefficient of forward voltage		ΔV _F / ΔΤα	I _F = 16mA	_	-1.9	_	mV / °C
Input reverse breakdown voltage		BVR	I _R = 10μA, Ta = 25°C	5	_	_	V
Input capacitance		CIN	f = 1MHz, V _F = 0	_	60	_	pF
Resistance (input–output)		RJ-o	V _{I-O} = 500V R.H. ≤ 60% (Note 9)	_	10 ¹²	_	Ω
Capacitance (input-output)	(7)	⟨ C _{I−O}	f = 1MHz (Note 9)	_	0.6	_	pF
Transistor DC current gain	2) (h _{FE}	V _O = 5V, I _O = 3mA	_	80	_	_

(**) All typical values are at Ta = 25°C



Switching Specifications (unless otherwise specified. Ta = 25°C, V_{CC} = 5V, I_F = 16mA)

Characteristic		Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit
Propagation delay time	6N135	t _{pHL}	1	$R_L = 4.1k\Omega$	_	0.2	1.5	μs
to logic low at output	6N136			$R_L = 1.9k\Omega$	_	0.2	0.8	μs
Propagation delay time	6N135	- t _{pLH}	1	$R_L = 4.1k\Omega$		1.0	1.5	μs
to logic high at output	6N136			$R_L = 1.9k\Omega$	(-)	0.5	0.8	μs
Common mode transient immunity	6N135	CM	2	$I_F = 0\text{mA}$ $V_{CM} = 10V_{p-p}$ $R_L = 4.1k\Omega$		1000	-	V / µs
at logic high level output (Note 10)	6N136	CM _H		$I_F = 0\text{mA}$ $V_{CM} = 10V_{p-p}$ $R_L = 1.9k\Omega$	_	1000	-	V / µs
Common mode transient immunity	6N135	· CM _L	2	$V_{CM} = 10V_{p-p}$ $R_L = 4.1k\Omega$ $I_F = 16mA$		1000	$/\!\!\!>$	V / µs
at logic low level output (Note 10)	6N136			V _{CM} = 10V _{p-p} R _L = 1.9kΩ I _F = 16mA		-1000	_	V / µs
Bandwidth ((Note 11)	BW	_	$R_L = 100\Omega$	7 =	2	_	MHz

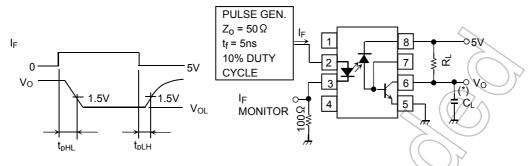
- (Note 8) DC current transfer ratio is defined as the ratio of output collector current, I_O, to the forward LED input current, I_F, times 100%.
- (Note 9) Device considered a two-terminal device: Pins 1, 2, 3 and 4 shorted together and pins 5, 6, 7 and 8 shorted together.
- (Note 10) Common mode transient immunity in logic high level is the maximum tolerable (positive) dV_{CM} / dt on the leading edge of the common mode pulse, V_{CM} , to assure that the output will remain in a logic high state (i.e., $V_O > 2.0V$).

Common mode transient immunity in logic low level is the maximum tolerable (negative) dV_{CM} / dt on the trailing edge of the common mode pulse signal, V_{CM} , to assure that the output will remain in a logic low state (i.e., $V_{CM} < 0.8V$).

(Note 11) The frequency at which the AC output voltage is 3dB below the low frequency asymptote.

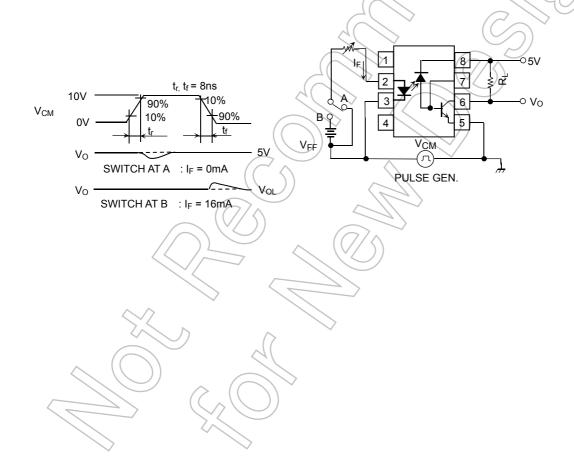


Test Circuit 1.

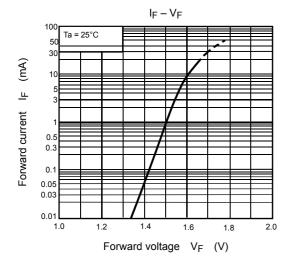


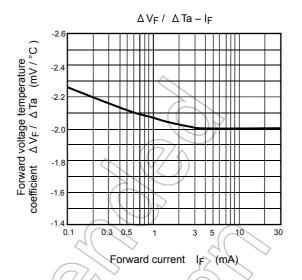
(*) C_L is approximately 15_PF which includes probe and stray wiring capacitance.

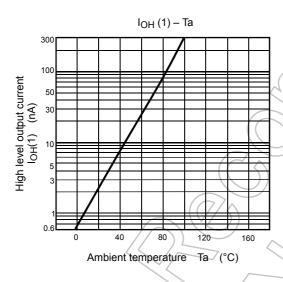
Test Circuit 2.

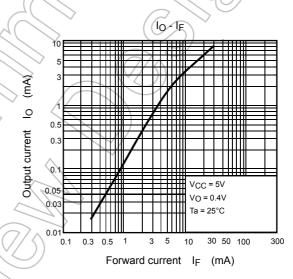


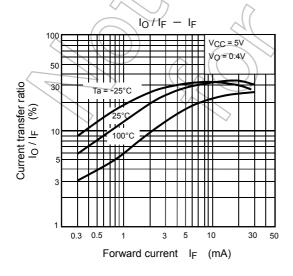
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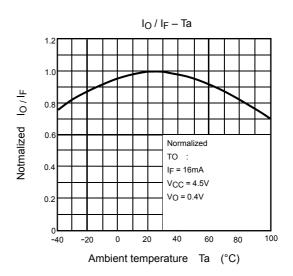


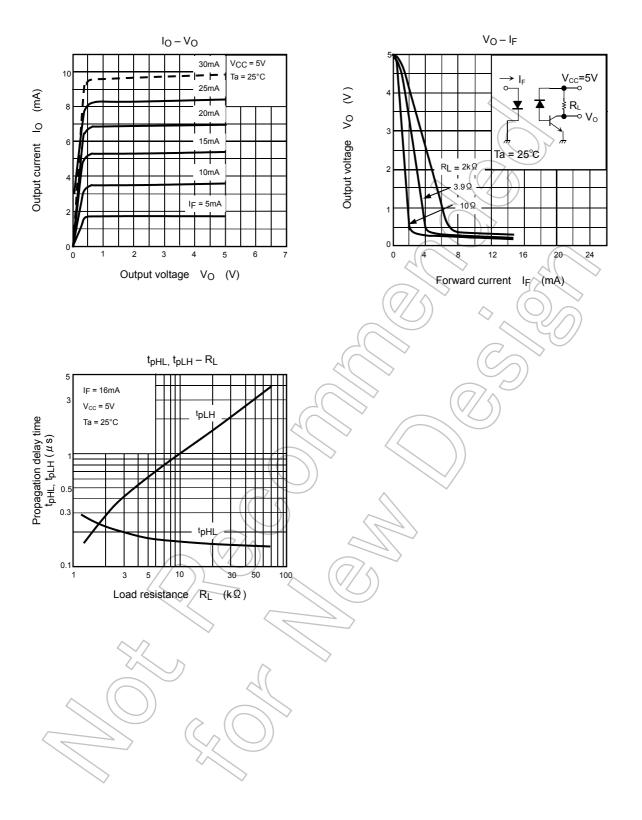












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8